

# Modeling and simulation of soft-particle colloids under dynamic environmental gradients



## Intro

- Directed assembly of soft-particle colloids is a bottom-up production method for nano-electronics, photonic devices, sensors/assays, bio-conjugate devices, and **functional coatings**. *In this work we direct with drying and irradiation of coatings!*
- Nanoparticles coated with bio-polymers are solvated and undergo hydrophilic / lithographic patterning, evaporation, irradiation processing to produce controlled nanoscale features. Colloids can also allow greater resolution in lithography.
- Our simulation method is versatile and easily modifiable. Bio-polymer and solvent interactions are course-grained to enable micron-scale simulation box sizes. We can correlate to experiment and parametrize order in several ways.

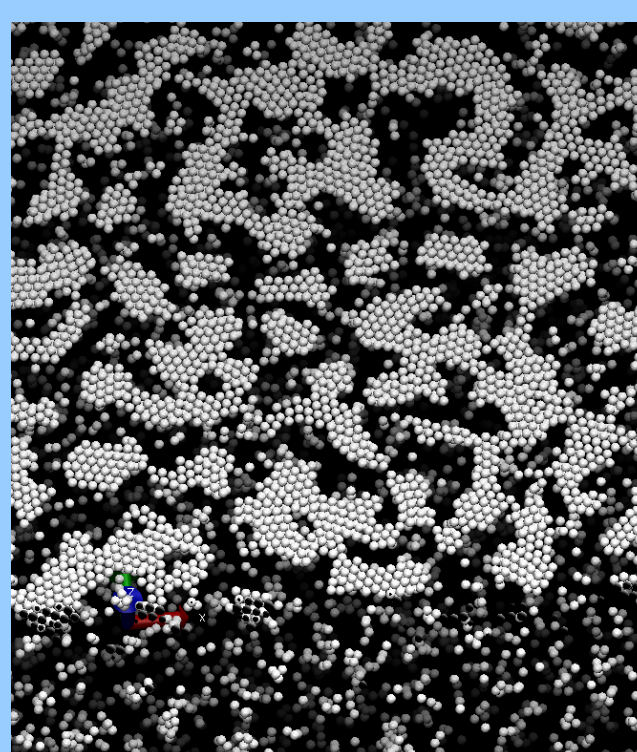
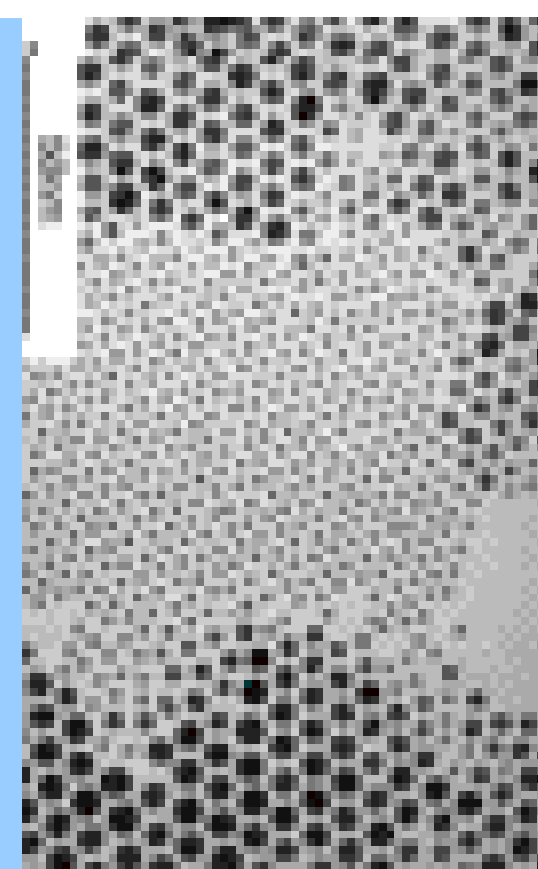
## Colloid Simulation

### Outcome of Nanoparticle Flow Project Consortium: Production Computational Tools for

- Rheology of Nanoparticle Suspensions<sup>1</sup>
- Drying and microstructure of self-and-directed assembly.

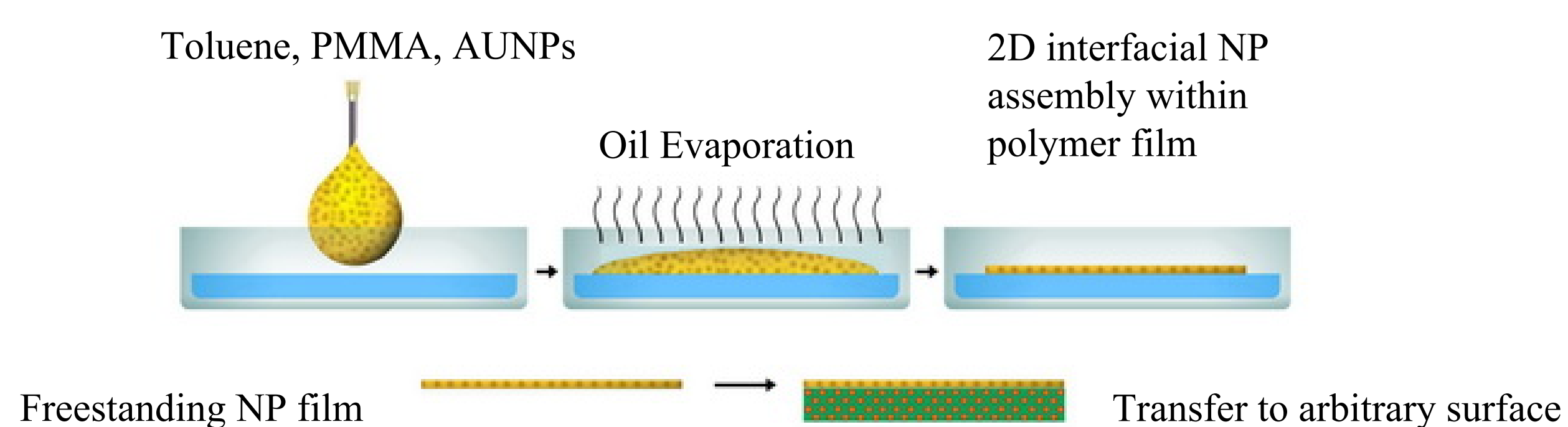
- Particles: Large-scale atomic/molecular massively parallel simulator (LAMMPS) discrete element solver allows coarse-grained force-interactions and is fully scalable.
- Solvent: Stokesian fast lubrication expedient (Higdon and Kumar 2009), and Flory-Huggins polymer-solvent dynamics.
- Shearing, fast-drying, irradiation, (non-equilibrium) dynamics are enabled by new custom LAMMPS code.

(image top right: bi-disperse nanoparticles in solution)  
(image bottom right: 3D soft-particle evap. simulation)  
1. Peterson et al., *J. Comp. Phys* 132, 174106, p 17046-1

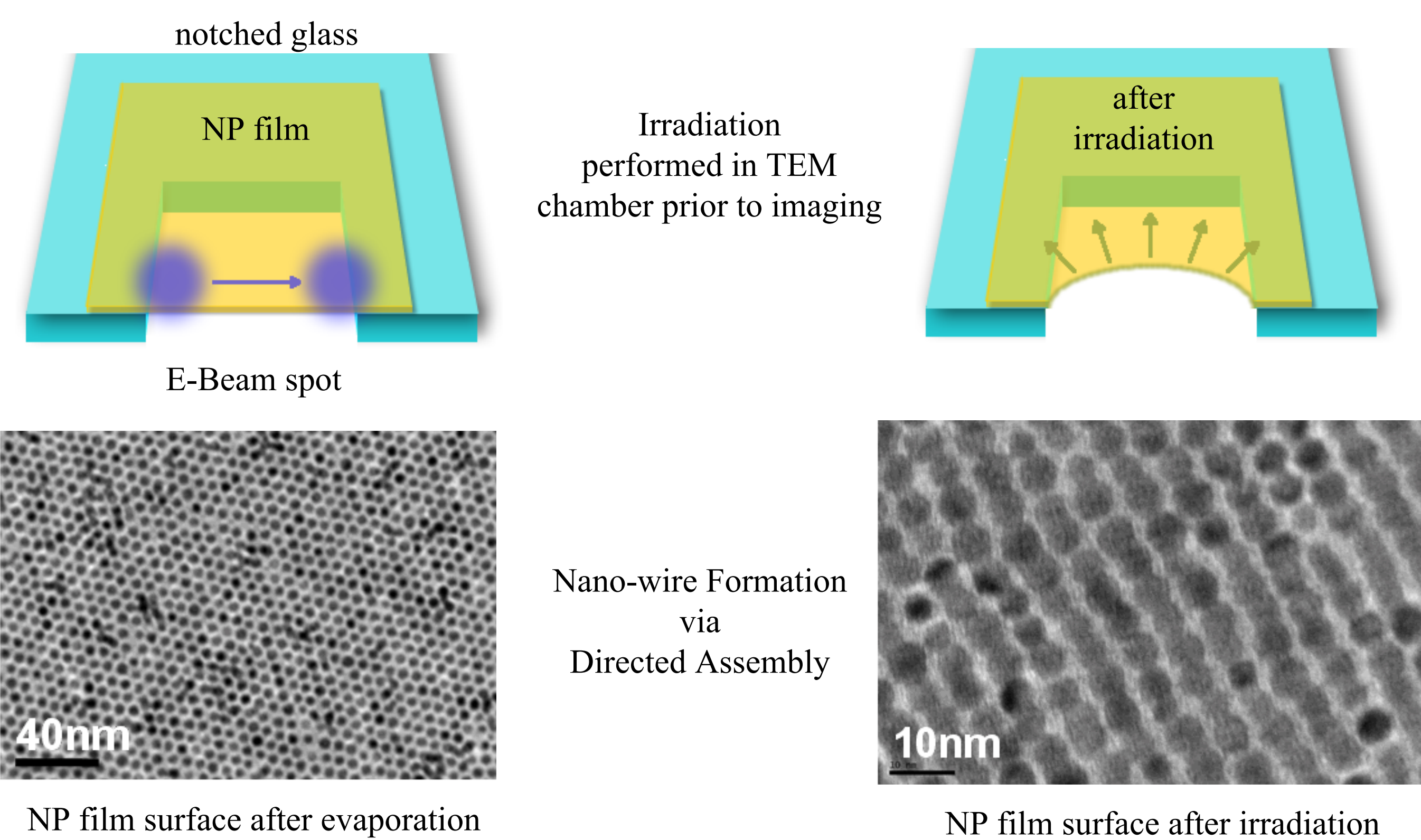


## Colloid Experiment

### 1) Evaporation-Induced Self-Assembly (EISA) at a fluid interface<sup>2</sup>



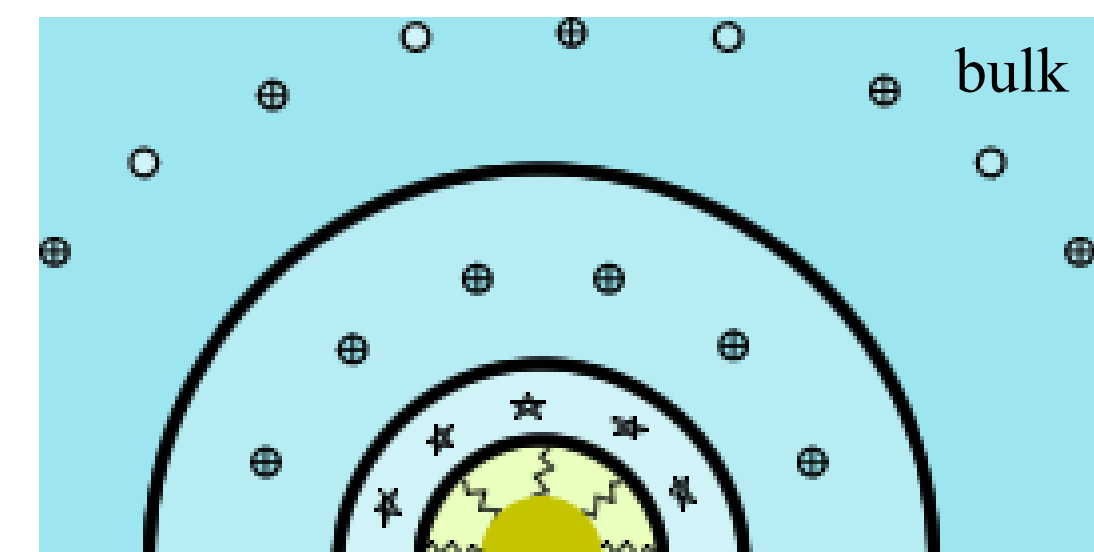
### 2) Directed assembly via e-beam irradiation (deformation)



2. J. Pang, S. Xiong, F. Jaeckel, Z. Sun, D. Dunphy, C.J. Brinker, *J. Am. Chem. Soc* 2008, 130, p 3284-3285

## Modelling soft-particles

- DLVO, polymer, lubrication forces are all coarse-grained to enable multi-scale simulations much larger than DFT or molecular methods can permit.
- Flory-Huggins theory for polymer/solvent interactions applied to spherical polymer-coated particles by Vincent<sup>3</sup>. Forces derived and integrated into LAMMPS code.
- Specific potentials in the Vincent model:
  - 1) bulk-polymer induced depletion
  - 2) polymer-polymer steric repulsion
  - 3) polymer-polymer elastic repulsion



Au core  
alkane coating  
polymer depletion layer  
solvent ionic double-layer

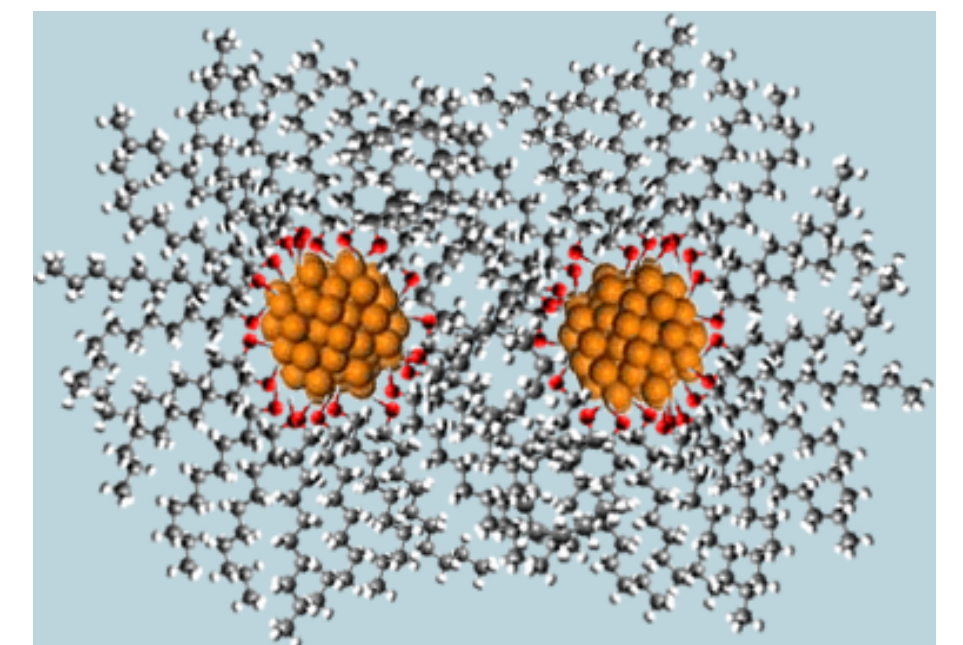
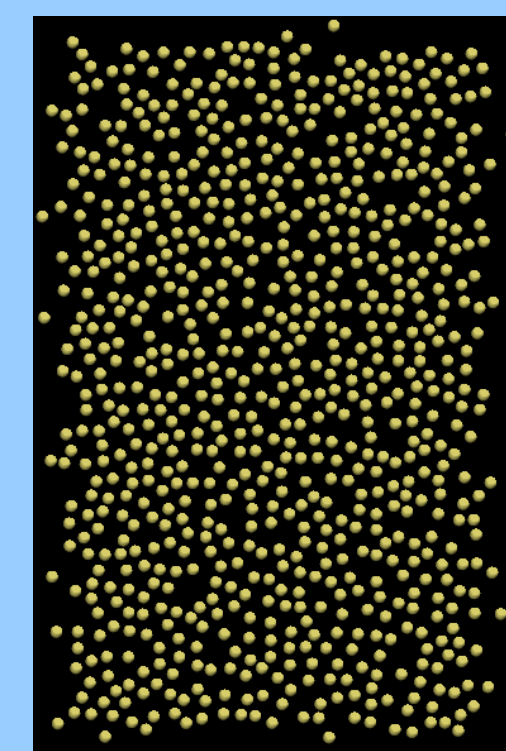


Diagram of Alkanethiolated AUNPs

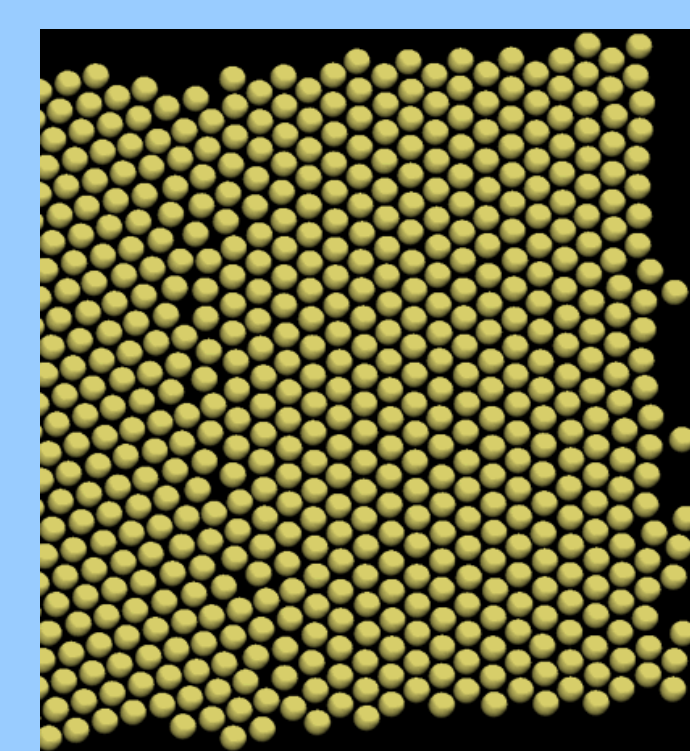
3. B. Vincent et al., *Colloids and Surfaces* 1986, 18, p. 261-281

## Results

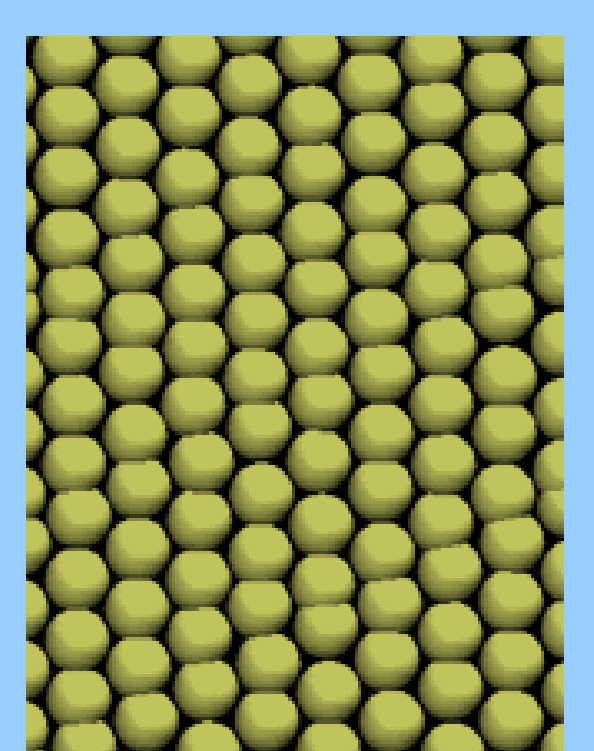
- 2D / 3D runs with up to 13K particles performed on the "nano" linux cluster at the UNM Center for Advanced Research Computing. Average simulation time O(ms), run time O(hrs).
- Nanoscale lines nearly identical to experiment were produced in simulation, underlying key parameters were revealed and new experimental methods for better assembly proposed.



2D equilibration

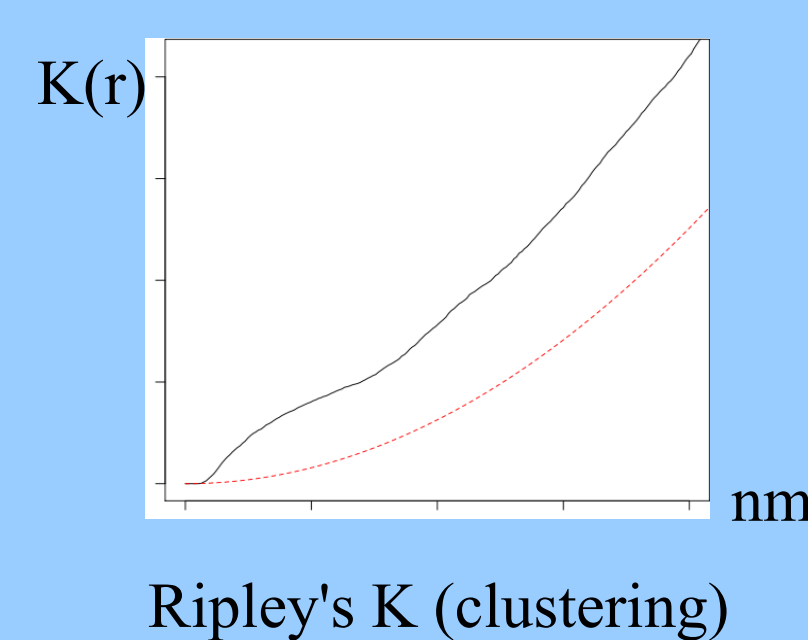


2D evaporation

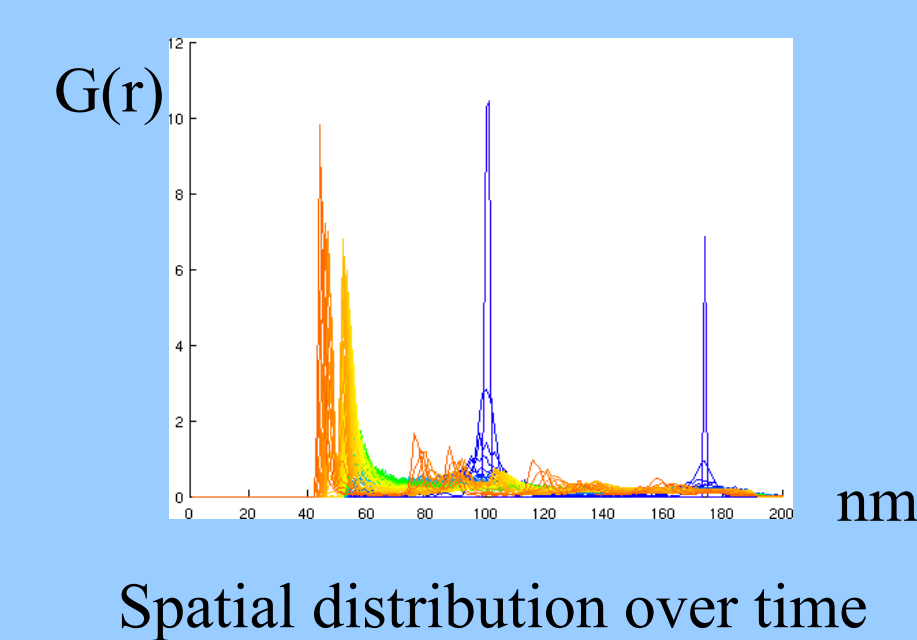


2D irradiation

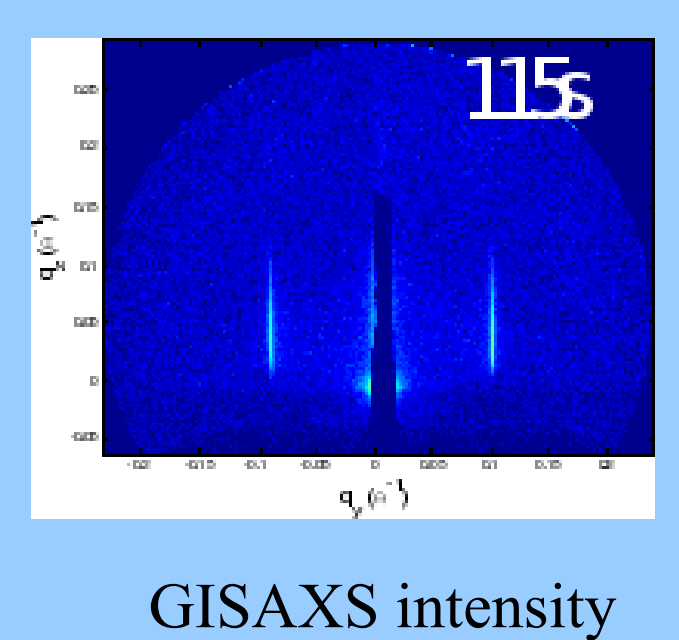
- Order parametrization methods include clustering / spatial distribution analysis, GISAXS, coordinate visualizations.
- Statistical methods from microbiology can be applied. We are also working on generating simulated GISAXS intensity plots from LAMMPS output files.



Ripley's K (clustering)



Spatial distribution over time



GISAXS intensity

## Conclusion

- We have extended LAMMPS to model soft-particle colloids and demonstrated matching between simulation and experiment.
- DEM simulation can yield insight into physical processes and provide guidance for improving experimental methods.
- New research directions include extending code for explicit surface interactions, new solvent / polymer materials for experiments, and new ideas for lithographic patterning and irradiation experiments.

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